

Search Notes

Application/Control No.

10/640,082

Examiner

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Applicant(s)/Patent under
Reexamination

LEE, CHANG-HYUN

Art Unit

2827

SEARCHED

Class	Subclass	Date	Examiner
365	185.17	6/7/2005	TNT
365	185.18	6/7/2005	TNT
365	185.23	6/7/2005	TNT
365	185.28	6/7/2003	TNT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
365	185.17	6/7/2005	TNT
365	185.18	6/7/2005	TNT
365	185.23	6/7/2005	TNT
365/185.28		6/7/2005	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	6/7/2005	TNT